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REFERENCE	DESIG	NATION U.S	PATENT DOCU	MENTS		
EXAMINER INITIAL		DOCUMENT NUMBER Number-Kind Gode (if known)	DATE	NAME	CLASS/ SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS **EXAMINER** TRANSLATION DOCUMENT CLASS/ YES OR NO INITIAL SUBCLASS NUMBER DATE COUNTRY F1 WO00/072119 09/14/2000 PCT F2 WQ00/54128 11/30/2000 PCT JP2002-539515 11/19/2002 Japan Yes (See WO0054128 above) F4 JP2003-500722 01/07/2003 Japan Yes (See W00/072119 above)

EXAMINER									
INITIAL	OTHER ART – NON PATENT LITERATURE DOCUMENTS								
1	(Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial,								
	symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.								
	F5 Japanese Patent Office Action for application no. 2003-096015 dated March 18, 2008 (including translation).								

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EXAMINER /Shin Hon Ci	nen/ DATE CON	SIDERED 06/06/2008	

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